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| <b>Search Notes</b><br><br> | <b>Application/Control No.</b><br><br>10829335 | <b>Applicant(s)/Patent Under Reexamination</b><br><br>LIN, WEN-CHIH |
|  | <b>Examiner</b><br><br>Benoit, Esther          | <b>Art Unit</b><br><br>2100   |

| SEARCHED |          |      |          |
|----------|----------|------|----------|
| Class    | Subclass | Date | Examiner |
|          |          |      |          |

| SEARCH NOTES                                  |            |          |
|---|------------|----------|
| Search Notes                                  | Date       | Examiner |
| Consulted with Primary Examiner Nabil El-Hady | 9/25/2007  | EB       |
| East Search History Attached                  | 9/26/2007  | EB       |
| East Search History Attached                  | 9/27/2007  | EB       |
| East Search History Attached                  | 10/01/2007 | EB       |
| Consulted with Primary Examiner Ario Etienne  | 10/02/2007 | EB       |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |